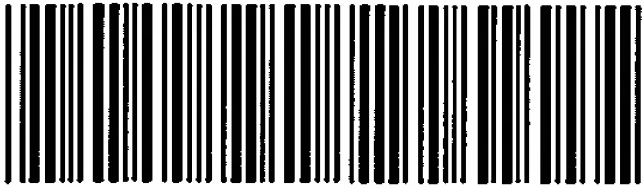


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/707,844	ISHIDA ET AL.	
	Examiner	Art Unit	
	Dana Farahani	2814	

SEARCHED			
Class	Subclass	Date	Examiner
257	728	1/26/2005	DF
"	730	1/26/2005	DF
"	731	1/26/2005	DF
"	288	1/26/2005	DF
"	289	1/26/2005	DF
"	368	1/26/2005	DF
"	379	1/26/2005	DF
"	382	1/26/2005	DF
"	383	1/26/2005	DF
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"	390	1/26/2005	DF
"	391	1/26/2005	DF
"	499	1/26/2005	DF
"	506	1/26/2005	DF

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	288	1/26/2005	DF
"	289	1/26/2005	DF
"	368	1/26/2005	DF

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
transistor\$1 and hole\$1	1/26/2005	DF
radiofrequency and hole\$1	1/26/2005	DF